# 74LV4094

# 8-stage shift-and-store bus register Rev. 5 — 18 March 2016

**Product data sheet** 

#### **General description** 1.

The 74LV4094 is a low voltage Si-gate CMOS device and is pin and functional compatible with 74HC4094; 74HCT4094.

The 74LV4094 is an 8-stage serial shift register. It has a storage latch associated with each stage for strobing data from the serial input to parallel buffered 3-state outputs QP0 to QP7. The parallel outputs may be connected directly to common bus lines. Data is shifted on positive-going clock transitions. The data in each shift register stage is transferred to the storage register when the strobe (STR) input is HIGH. Data in the storage register appears at the outputs whenever the output enable (OE) signal is HIGH.

Two serial outputs (QS1 and QS2) are available for cascading a number of 74LV4094 devices. Serial data is available at QS1 on positive-going clock edges to allow high-speed operation in cascaded systems with a fast clock rise time. The same serial data is available at QS2 on the next negative going clock edge. This is used for cascading 74LV4094 devices when the clock has a slow rise time.

#### Features and benefits 2.

- Optimized for low voltage applications: 1.0 V to 3.6 V
- Accepts TTL input levels between V<sub>CC</sub> = 2.7 V and V<sub>CC</sub> = 3.6 V
- Typical output ground bounce < 0.8 V at  $V_{CC}$  = 3.3 V and  $T_{amb}$  = 25 °C
- Typical HIGH-level output voltage (V<sub>OH</sub>) undershoot: > 2 V at V<sub>CC</sub> = 3.3 V and  $T_{amb} = 25 \, ^{\circ}C$
- ESD protection:
  - HBM JESD22-A114E exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from −40 °C to +85 °C and from −40 °C to +125 °C

## **Applications**

- Serial-to-parallel data conversion
- Remote control holding register



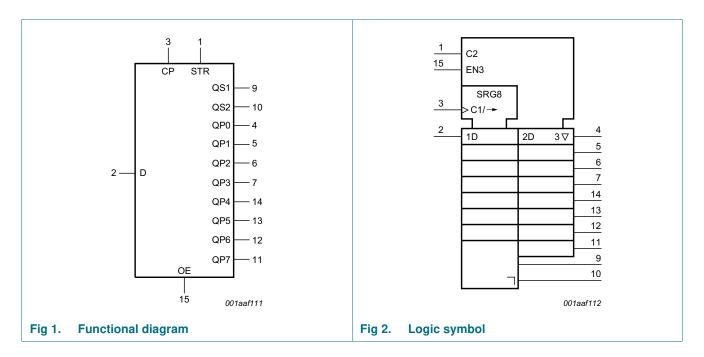
#### 8-stage shift-and-store bus register

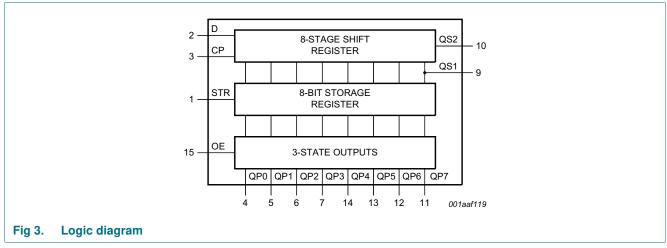
## 4. Ordering information

Table 1. Ordering information

Type number	Package	Package								
	Temperature range	Name	Description	Version						
74LV4094D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1						
74LV4094DB	–40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1						
74LV4094PW	–40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1						

## 5. Functional diagram



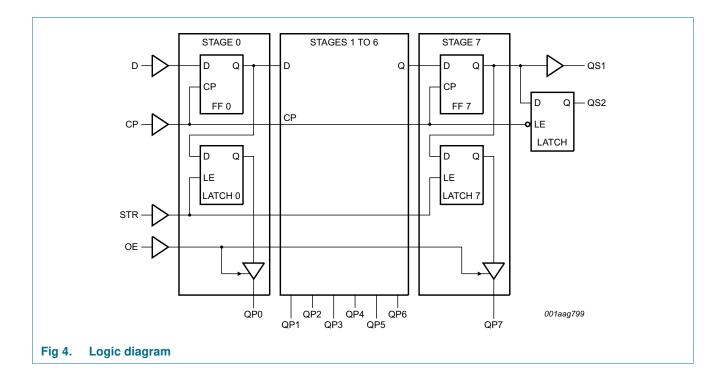


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**Product data sheet** 

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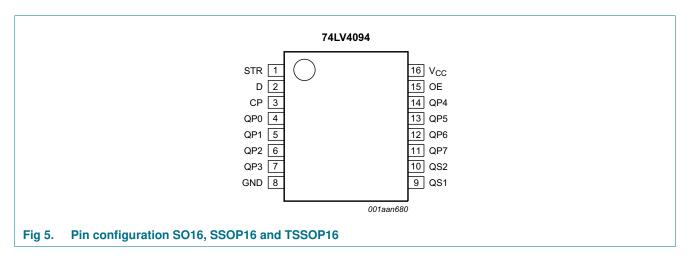
### 8-stage shift-and-store bus register



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## 6. Pinning information

## 6.1 Pinning



## 6.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
STR	1	strobe input
D	2	data input
СР	3	clock input
QP0 to QP7	4, 5, 6, 7, 14, 13, 12, 11	parallel output
GND	8	ground supply voltage
QS1, QS2	9,10	serial output
OE	15	output enable input
V <sub>CC</sub>	16	supply voltage

#### 8-stage shift-and-store bus register

## 7. Functional description

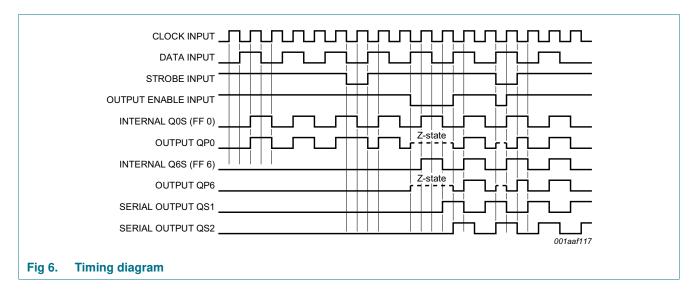
Table 3. Function table[1]

Inputs			Parallel o	outputs	Serial out	Serial outputs	
СР	OE	STR	D	QP0	QPn	QS1	QS2
$\uparrow$	L	X	X	Z	Z	Q6S	NC
$\downarrow$	L	X	Х	Z	Z	NC	Q7S
$\uparrow$	Н	L	Х	NC	NC	Q6S	NC
$\uparrow$	Н	Н	L	L	QPn –1	Q6S	NC
$\uparrow$	Н	Н	Н	Н	QPn –1	Q6S	NC
$\overline{\downarrow}$	Н	Н	Н	NC	NC	NC	Q7S

<sup>[1]</sup> At the positive clock edge, the information in the 7th register stage is transferred to the 8th register stage and the QSn outputs.

Q6S = the data in register stage 6 before the LOW to HIGH clock transition;

Q7S = the data in register stage 7 before the HIGH to LOW clock transition.



H = HIGH voltage level; L = LOW voltage level; X = don't care;

 $<sup>\</sup>uparrow$  = positive-going transition;  $\downarrow$  = negative-going transition;

Z = HIGH-impedance OFF-state; NC = no change;

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## 8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+7	V
I <sub>IK</sub>	input clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$	-	±20	mA
I <sub>OK</sub>	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$	-	±50	mA
Io	output current	$V_{O} = -0.5 \text{ V to } (V_{CC} + 0.5 \text{ V})$	-	±25	mA
I <sub>CC</sub>	supply current		-	+50	mA
I <sub>GND</sub>	ground current		-50	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$			
		SO16 package	1 -	500	mW
		(T)SSOP16 package	1 -	500	mW

<sup>[1]</sup> For SO16 package:  $P_{tot}$  derates linearly with 8 mW/K above 70 °C.

## 9. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage	[1]	1.0	3.3	3.6	V
VI	input voltage		0	-	V <sub>CC</sub>	٧
Vo	output voltage		0	-	V <sub>CC</sub>	٧
T <sub>amb</sub>	ambient temperature		-40	+25	+125	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 1.0 V to 2.0 V	-	-	500	ns/V
		V <sub>CC</sub> = 2.0 V to 2.7 V	-	-	200	ns/V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	-	100	ns/V

<sup>[1]</sup> The static characteristics are guaranteed from  $V_{CC}$  = 1.2 V to  $V_{CC}$  = 5.5 V, but LV devices are guaranteed to function down to  $V_{CC}$  = 1.0 V (with input levels GND or  $V_{CC}$ ).

<sup>[2]</sup> For SSOP16 and TSSOP16 packages: Ptot derates linearly with 5.5 mW/K above 60 °C.

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## 10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to 85	o°C	-40 °C to +125 °C		Unit
			Min	Typ[1]	Max	Min	Max	
V <sub>IH</sub>	HIGH-level	V <sub>CC</sub> = 1.2 V	V <sub>CC</sub>	0.6	-	V <sub>CC</sub>	-	٧
	input voltage	V <sub>CC</sub> = 2.0 V	1.4	-	-	1.4	-	٧
		V <sub>CC</sub> = 2.7 V to 3.6 V	2.0	-	-	2.0	-	٧
$V_{IL}$	LOW-level	V <sub>CC</sub> = 1.2 V	-	0.4	GND	-	GND	٧
	input voltage	$V_{CC} = 2.0 \text{ V}$	-	-	0.6	-	0.6	٧
		V <sub>CC</sub> = 2.7 V to 3.6 V	-	-	0.8	-	0.8	٧
$V_{OH}$	HIGH-level	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; all pins						
	output voltage	$I_{O} = -100 \mu A; V_{CC} = 1.2 V$	-	1.2	-	-	-	٧
		$I_{O} = -100 \ \mu A; \ V_{CC} = 2.0 \ V$	1.8	2.0	-	1.8	-	٧
		$I_{O} = -100 \mu A; V_{CC} = 2.7 V$	2.5	2.7	-	2.5	-	٧
		$I_{O} = -100 \ \mu A; \ V_{CC} = 3.0 \ V$	2.8	3.0	-	2.8	-	٧
		$V_I = V_{IH}$ or $V_{IL}$ ; pins QPn						
		$I_{O} = -6 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.40	2.82	-	2.20	-	V
$V_{OL}$	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; all pins						
		$I_O = 100 \mu A; V_{CC} = 1.2 V$	-	0	-	-	-	V
		$I_O = 100 \mu A; V_{CC} = 2.0 V$	-	0	0.2	-	0.2	V
		$I_O = 100 \mu A; V_{CC} = 2.7 V$	-	0	0.2	-	0.2	V
		$I_O = 100 \ \mu A; \ V_{CC} = 3.0 \ V$	-	0	0.2	-	0.2	V
		$V_I = V_{IH}$ or $V_{IL}$ ; pins QPn						
		$I_O = 6 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	0.25	0.40	-	0.50	V
l <sub>l</sub>	input leakage current	$V_1 = V_{CC}$ or GND; $V_{CC} = 3.6 \text{ V}$	-	-	±1.0	-	±1.0	μА
l <sub>OZ</sub>	OFF-state output current	$V_I = V_{IH}$ or $V_{IL}$ ; $V_O = V_{CC}$ or GND; $V_{CC} = 3.6 \text{ V}$	-	-	±5.0	-	±10.0	μΑ
I <sub>CC</sub>	supply current	$V_1 = V_{CC}$ or GND; $I_0 = 0$ A; $V_{CC} = 3.6$ V	-	-	20.0	-	160	μΑ
$\Delta I_{CC}$	additional supply current	per input; $V_I = V_{CC} - 0.6 \text{ V};$ $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	-	500.0	-	850	μΑ
Cı	input capacitance		-	3.5	-	-	-	pF

<sup>[1]</sup> All typical values are measured at  $T_{amb}$  = 25 °C.

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## 11. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); C<sub>L</sub> = 50 pF unless otherwise specified; for test circuit see Figure 11.

Symbol	Parameter	Conditions		-40	°C to 85	°C	–40 °C t	o +125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
t <sub>pd</sub>	propagation	CP to QS1; see Figure 7	<u>[3]</u>						
	delay	V <sub>CC</sub> = 1.2 V		-	90	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	31	58	-	70	ns
		V <sub>CC</sub> = 2.7 V		-	23	43	-	51	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	[2]	-	17	34	-	41	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$		-	14	-	-	-	ns
		CP to QS2; see Figure 7	[3]						
		V <sub>CC</sub> = 1.2 V		-	80	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	27	51	-	61	ns
		V <sub>CC</sub> = 2.7 V		-	20	38	-	45	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		-	14	30	-	36	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$			13	-	-	-	ns
	CP to QPn; see Figure 7	[3]							
	V <sub>CC</sub> = 1.2 V		-	115	-	-	-	ns	
		V <sub>CC</sub> = 2.0 V		-	39	75	-	90	ns
		V <sub>CC</sub> = 2.7 V		-	29	55	-	66	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[2]	-	22	44	-	53	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$		-	18	-	-	-	ns
		STR to QPn; see Figure 8	[3]						
		V <sub>CC</sub> = 1.2 V		-	105	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	36	68	-	82	ns
		V <sub>CC</sub> = 2.7 V		-	26	50	-	60	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[2]	-	20	40	-	48	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$		-	17	-	-	-	ns
t <sub>en</sub>	enable time	OE to QPn; see Figure 10	[4]						
		V <sub>CC</sub> = 1.2 V		-	100	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	34	65	-	77	ns
		V <sub>CC</sub> = 2.7 V		-	25	48	-	56	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[2]	-	19	38	-	45	ns
t <sub>dis</sub>	disable time	OE to QPn; see Figure 10	<u>[5]</u>						
		V <sub>CC</sub> = 1.2 V		-	65	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	24	40	-	49	ns
		V <sub>CC</sub> = 2.7 V		-	18	32	-	37	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[2]	-	14	26	-	30	ns

### 8-stage shift-and-store bus register

 Table 7.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V);  $C_L$  = 50 pF unless otherwise specified; for test circuit see Figure 11.

Symbol	Parameter	Conditions		-40	°C to 85	°C	-40 °C to +125 °C		Unit
				Min	Typ[1]	Max	Min	Max	
t <sub>W</sub>	pulse width	CP HIGH or LOW; see Figure 7							
		V <sub>CC</sub> = 2.0 V		34	9	-	41	-	ns
		V <sub>CC</sub> = 2.7 V		25	6	-	30	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	2]	20	5	-	24	-	ns
		STR HIGH; see Figure 8							
		V <sub>CC</sub> = 2.0 V		34	9	-	41	-	ns
		V <sub>CC</sub> = 2.7 V		25	6	-	30	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	2]	20	5	-	24	-	ns
t <sub>su</sub> set-up time	D to CP; see Figure 9								
		V <sub>CC</sub> = 1.2 V		-	25	-	-	-	ns
	V <sub>CC</sub> = 2.0 V		22	9	-	26	-	ns	
	V <sub>CC</sub> = 2.7 V		16	6	-	19	-	ns	
	V <sub>CC</sub> = 3.0 V to 3.6 V	2]	13	5	-	15	-	ns	
		CP to STR; see Figure 8							
		V <sub>CC</sub> = 1.2 V		-	50	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		43	17	-	51	-	ns
		V <sub>CC</sub> = 2.7 V		31	13	-	38	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	2]	25	10	-	30	-	ns
t <sub>h</sub>	hold time	D to CP; see Figure 9							
		V <sub>CC</sub> = 1.2 V		-	-10	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		5	-4	-	+5	-	ns
		V <sub>CC</sub> = 2.7 V		5	-3	-	+5	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	2]	5	-2	-	+5	-	ns
		CP to STR; see Figure 8							
		V <sub>CC</sub> = 1.2 V		-	-25	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		5	-9	-	+5	-	ns
		V <sub>CC</sub> = 2.7 V		5	-6	-	+5	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	2]	5	-5	-	+5	-	ns
max	maximum	CP; see Figure 7							
	frequency	V <sub>CC</sub> = 2.0 V		14	52	-	12	-	MHz
		V <sub>CC</sub> = 2.7 V		19	70	-	16	-	MHz
		V <sub>CC</sub> = 3.0 V to 3.6 V		24	87	-	20	-	MHz
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$	2]	-	95	-	-	-	MHz

#### 8-stage shift-and-store bus register

 Table 7.
 Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); C<sub>L</sub> = 50 pF unless otherwise specified; for test circuit see Figure 11.

Symbol	Parameter	Conditions	-40 °C to 85 °C		–40 °C t	Unit		
			Min	Typ[1]	Max	Min	Max	
C <sub>PD</sub>	power dissipation capacitance	$C_L = 50 \text{ pF}; f = 1 \text{ MHz};$ $V_I = \text{GND to } V_{CC}$	-	83	-	-	-	pF

- [1] All typical values are measured at  $T_{amb}$  = 25 °C.
- [2] All typical values are measured at  $V_{CC} = 3.3 \text{ V}$ .
- [3]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .
- [4]  $t_{en}$  is the same as  $t_{PZH}$  and  $t_{PZL}$ .
- [5]  $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .
- [6]  $t_t$  is the same as  $t_{THL}$  and  $t_{TLH}$ .
- [7]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

$$P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times N + \sum (C_L \times V_{CC}{}^2 \times f_o)$$
 where:

f<sub>i</sub> = input frequency in MHz;

fo = output frequency in MHz;

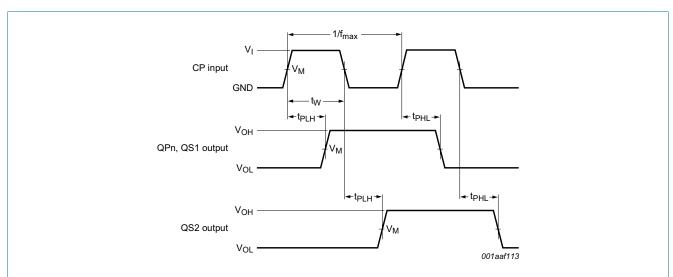
C<sub>L</sub> = output load capacitance in pF;

V<sub>CC</sub> = supply voltage in V;

N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$ 

#### 12. Waveforms



Measurement points are given in Table 8.

 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical voltage output levels that occur with the output load.

Fig 7. Propagation delay input (CP) to output (QPn, QS1, QS2), output transition time, clock input (CP) pulse width and the maximum frequency (CP)

#### 8-stage shift-and-store bus register

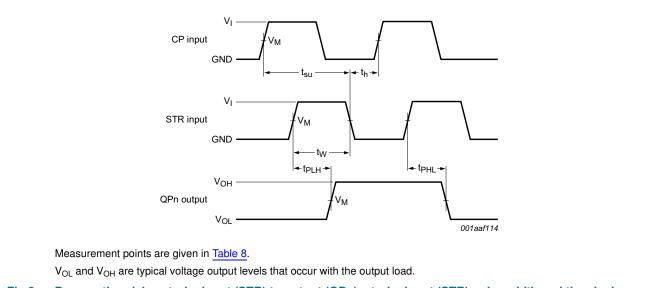
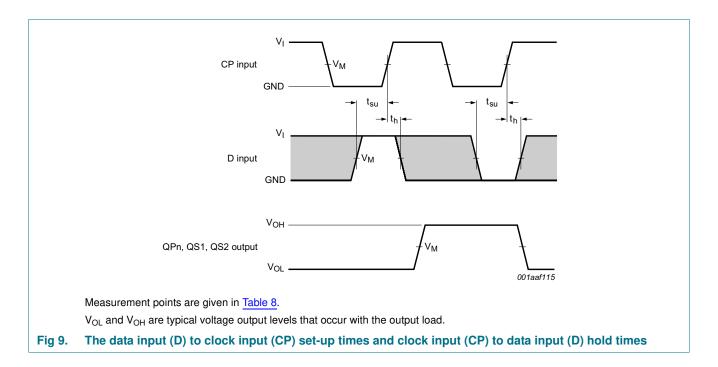
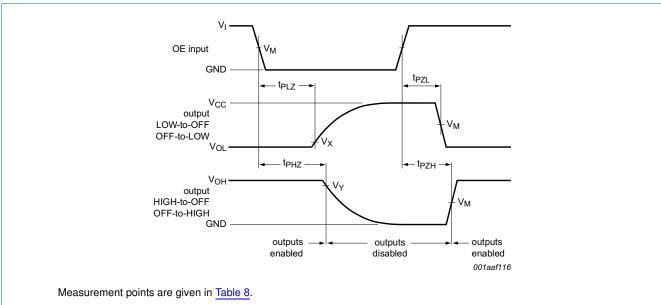


Fig 8. Propagation delay strobe input (STR) to output (QPn), strobe input (STR) pulse width and the clock set-up and hold times for strobe input



### 8-stage shift-and-store bus register



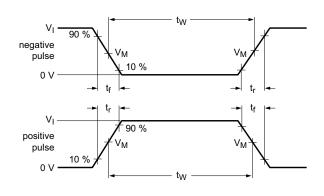
 $\ensuremath{V_{OL}}$  and  $\ensuremath{V_{OH}}$  are typical voltage output levels that occur with the output load.

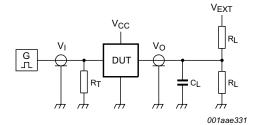
Fig 10. Enable and disable times

Table 8. Measurement points

Supply voltage	Input	Output					
V <sub>CC</sub>	V <sub>M</sub>	V <sub>M</sub>	V <sub>X</sub>	V <sub>Y</sub>			
< 2.7 V	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>	$V_{OL} + 0.1V_{CC}$	V <sub>OH</sub> – 0.1V <sub>CC</sub>			
2.7 V to 3.6 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> – 0.3 V			

#### 8-stage shift-and-store bus register





Test data is given in Table 9.

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

 $V_{EXT}$  = External voltage for measuring switching times.

Fig 11. Test circuit for measuring switching times

Table 9. Test data

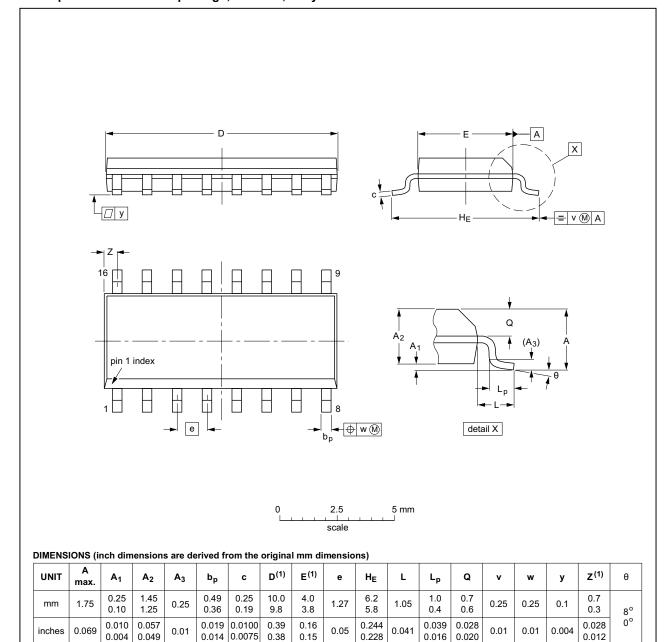
Supply voltage	Input		Load		V <sub>EXT</sub>		
V <sub>CC</sub>	V <sub>I</sub>	t <sub>r</sub> , t <sub>f</sub>	C <sub>L</sub>	R <sub>L</sub>	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	$t_{PZL}, t_{PLZ}$
< 2.7 V	V <sub>CC</sub>	≤ 2.5 ns	50 pF	1 kΩ	open	GND	2V <sub>CC</sub>
2.7 V to 3.6 V	2.7 V	≤ 2.5 ns	15 pF, 50 pF	1 kΩ	open	GND	2V <sub>CC</sub>

#### 8-stage shift-and-store bus register

## 13. Package outline

#### SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	IOOUE DATE		
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT109-1	076E07	MS-012			<del>99-12-27</del> 03-02-19	

Fig 12. Package outline SOT109-1 (SO16)

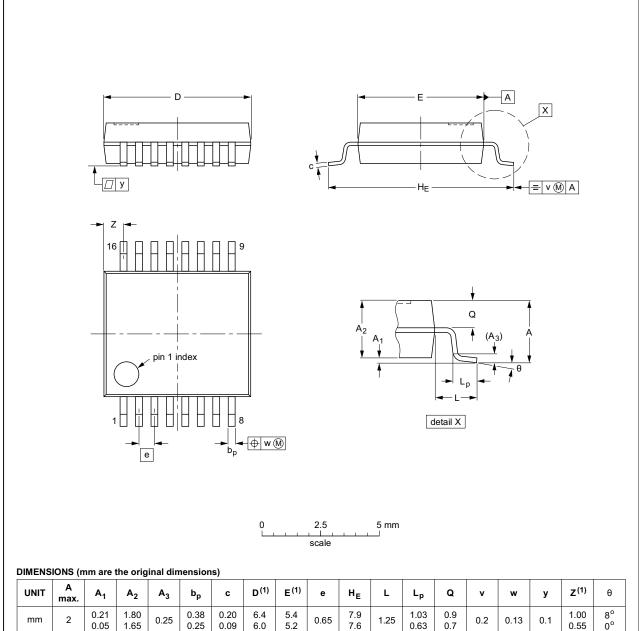
741 V4094

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74LV4094 **NXP Semiconductors** 

SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm

SOT338-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	٧	w	у	Z <sup>(1)</sup>	θ	
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.00 0.55	8° 0°	

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE		
SOT338-1		MO-150			<del>99-12-27</del> 03-02-19		

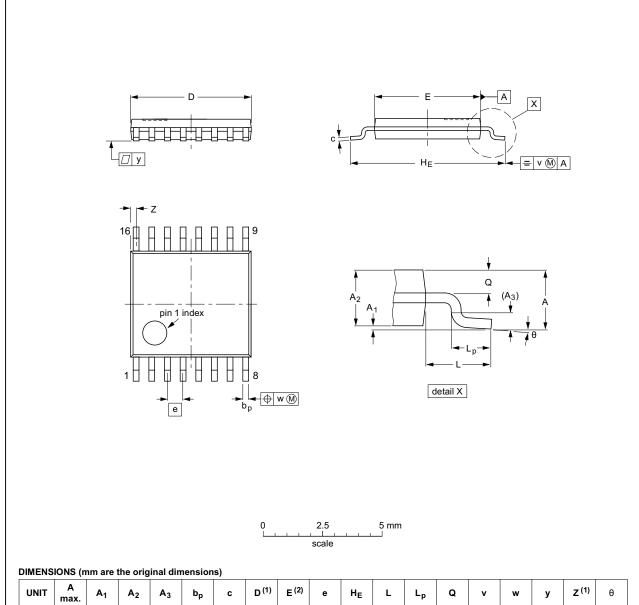
Fig 13. Package outline SOT338-1 (SSOP16)

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#### 8-stage shift-and-store bus register

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



UNI	IT	A max.	<b>A</b> <sub>1</sub>	A <sub>2</sub>	<b>A</b> <sub>3</sub>	b <sub>p</sub>	С	D <sup>(1)</sup>	E (2)	е	HE	L	Lp	Q	٧	w	у	Z <sup>(1)</sup>	θ
mn	n	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

	OUTLINE		REFER	EUROPEAN	ISSUE DATE			
	VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
	SOT403-1		MO-153				<del>-99-12-27</del> 03-02-18	
L	SOT403-1		MO-153				$\exists \oplus$	

Fig 14. Package outline SOT403-1 (TSSOP16)

74LV4094

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8-stage shift-and-store bus register

## 14. Abbreviations

#### Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 15. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LV4094 v.5	20160318	Product data sheet	-	74LV4094 v.4
Modifications:	Type number	er 74LV4094N (SOT38-4) r	emoved.	
74LV4094 v.4	20111219	Product data sheet	-	74LV4094 v.3
Modifications:	<ul> <li>Legal pages</li> </ul>	updated.		
74LV4094 v.3	20110307	Product data sheet	-	74LV4094 v.2
74LV4094 v.2	20060629	Product data sheet	-	74LV4094 v.1
74LV4094 v.1	19980623	Product specification	-	-

#### 8-stage shift-and-store bus register

## 16. Legal information

#### 16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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